

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10590630	JENSEN ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Young J Kim	1637

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
reviewed search strategy for 10/590,632	11/14/2008	/YJK/
Patent Databases (USPT, USPPG, EPO, JPO, DERWENT, IBM-TDB) - see enclosed for text-search strategy	8/6/2009	/YJK/
NPL - search terms: spore, lysis, alternating electric field, bacterial/bacteria spore.	8/6/2009	/YJK/

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

	/Young J Kim/ Primary Examiner.Art Unit 1637
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